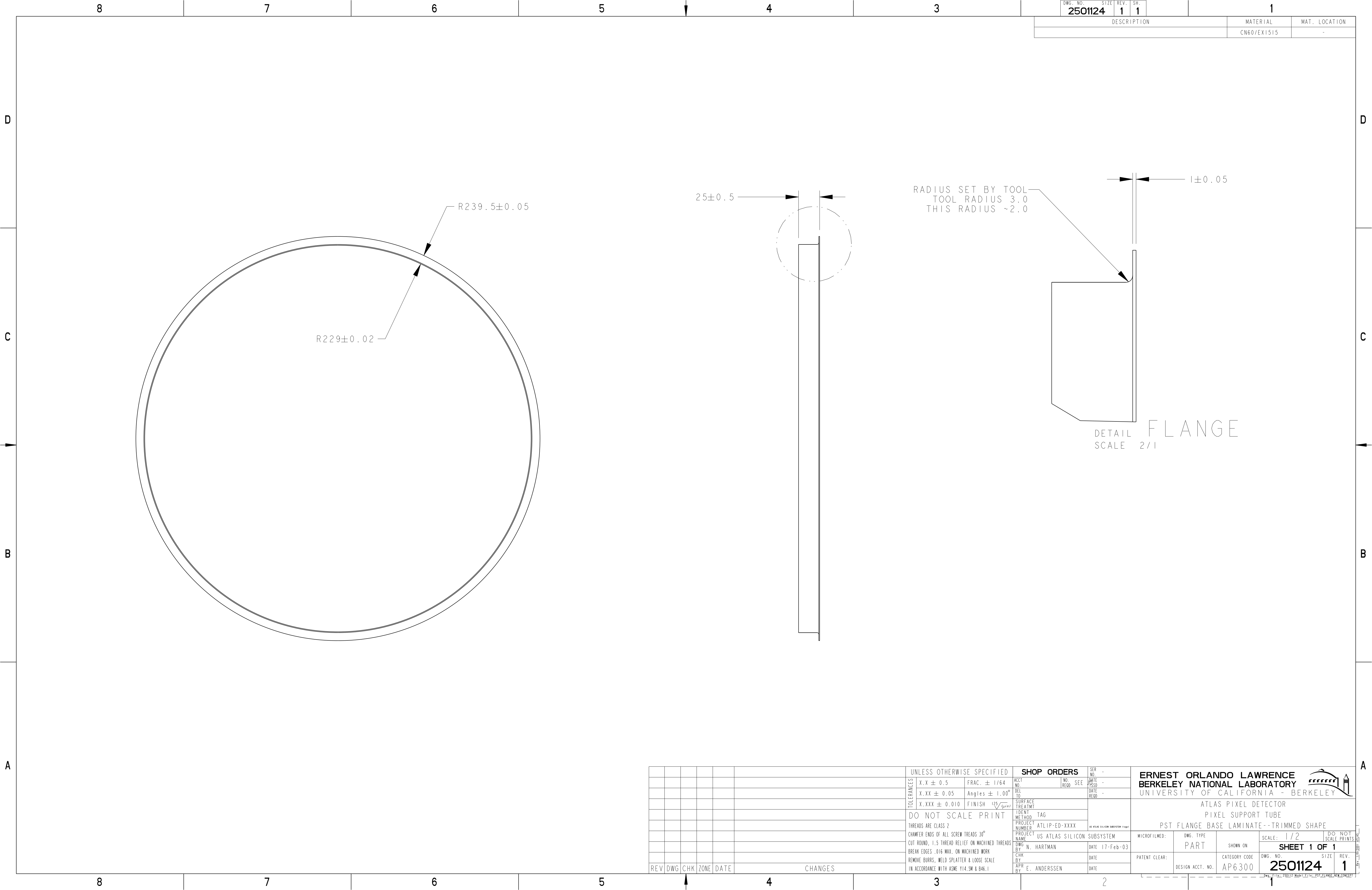




						UNLESS OTHERWISE SPECIFIED		SHOP ORDERS		SER. NO. -	ERNEST ORLANDO LAWRENCE BERKELEY NATIONAL LABORATORY UNIVERSITY OF CALIFORNIA - BERKELEY 						
						TOLERANCES	X.X ± 0.5	FRAC. ± 1/64	ACCT. NO.	NO. REQD.					SEE	DATE ISSD -	
							X.XX ± 0.05	Angles ± 1.00°	DEL. TO							DATE REQD. -	
							X.XXX ± 0.010	FINISH 125√ <i>μ</i> ⁱⁿ	SURFACE TREATMT								
						DO NOT SCALE PRINT			IDENT. METHOD	TAG							
						THREADS ARE CLASS 2			PROJECT NUMBER	ATLIP-ED-XXXX	US ATLAS SILICON SUBSYSTEM (110001)						
						CHAMFER ENDS OF ALL SCREW TREADS 30°			PROJECT NAME	US ATLAS SILICON SUBSYSTEM	MICROFILMED:		DWG. TYPE	SHOWN ON	SCALE: 1/2	DO NOT SCALE PRINTS	
						CUT ROUND, 1.5 THREAD RELIEF ON MACHINED THREADS			DWG. BY	N. HARTMAN	DATE	17-Feb-03	PART		SHEET 1 OF 1		
						BREAK EDGES .016 MAX. ON MACHINED WORK			CHK. BY		DATE		PATENT CLEAR:	CATEGORY CODE	DWG. NO.	SIZE	REV.
						REMOVE BURRS, WELD SPATTER & LOOSE SCALE			APR. BY	E. ANDERSSSEN	DATE			DESIGN ACCT. NO. AP6300	2501124	1	
						IN ACCORDANCE WITH ASME Y14.5M & B46.1											
REV	DWG	CHK	ZONE	DATE	CHANGES												